

Notice of References Cited

Application/Control No.

09/687,699

Applicant(s)/Patent-Under
Reexamination
LIN ET AL.

Examiner

Kim T. Huynh

Art Unit

2189

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,463,498	10-2002	Wakeley et al.	710/309
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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